

Broadband terahertz time-domain polarimetry based on air plasma filament emissions and spinning electro-optic sampling in GaP

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ABSTRACT

We report on a time-domain polarimetry (TDP) system for generating and detecting broadband terahertz (THz) waves of different polarization angles. We generate THz waves from two-color laser filaments and determine their polarization states with a detection bandwidth of up to 8 THz using a spinning gallium phosphide crystal. The polarization of THz emission can be controlled by adjusting the position and tilt angle of the β -barium borate crystal. We characterize the precision of this system for polarimetric measurements at fixed time delay to be 1.6° and 1.9° for complete time-domain waveforms. We also demonstrate the feasibility of our TDP system by measuring broadband optical properties of anisotropic samples in both transmission and reflection geometries. The THz-TDP technique can be easily integrated in conventional THz time-domain spectroscopy setups using nonlinear crystal detectors.

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Polarimetry refers to the measurement of the polarization state of electromagnetic waves transmitted through or reflected by samples. The polarization information of THz waves can be used in different aspects of material characterization such as the ellipsometric measurement of thin-films,¹ the detection of the birefringence and optical axis of samples,² and the investigation of THz magneto-optic properties of materials.³ Compared to optical polarimetry, limited availability of achromatic THz polarization elements has made full polarimetric measurement of broadband THz beams challenging. Polarization-sensitive detection in the THz regime is usually obtained using wire-grid polarizers. Current wire grid polarizers can reach 30–40 dB extinction ratio (ER) at lower THz frequencies (<1 THz).^{4,5} However, the extinction ratio is not constant and is significantly reduced at higher frequencies.⁶ The leakage of high frequency components, hence, becomes an intrinsic error when wire-grid polarizers are used in ultra-broadband THz measurements such as those made using gas plasma filaments.

There are several THz polarimetry techniques that do not rely on the use of additional polarization elements. For example, photoconductive antenna detectors are inherently polarization-dependent, since the antenna gap has a certain orientation. Multi-contact antennas with

more than one gap are, thus, fabricated to measure the orthogonal components simultaneously.^{7–9} Another strategy is to use the orientation dependence of the electro-optic (EO) sampling technique to resolve a polarization state of the THz beams. The EO responses in zinc blende crystals have a robust relation with the THz polarization, crystal axis, and polarization direction of the probe beam.¹⁰ Polarization measurements are, thus, achieved by manually rotating the direction of the probe beam¹¹ or the detector crystal.¹² In order to improve the precision and the speed of this method, automatic control and data acquisition have been introduced to replace the steps of manual rotation. Electronic control has been made by polarization or amplitude modulation of the probe beam.^{13,14} Alternatively, the EO crystal can be oriented to specific angles using a motorized rotary stage.¹⁵ In addition, we have used a continuously spinning EO crystal at a fixed rotational frequency to extract the polarization angle of the THz waves through the Fourier transform in a lock-in type detection technique.^{16,17} However, the bandwidth of our previous TDP system, which utilized 1-mm-thick ZnTe crystals as the emitter and detector, was limited to approximately 2 THz.

Air plasma driven by two-color laser pulses are able to emit broadband THz waves.^{18,19} In this Letter, we propose a THz-TDP

system, which uses a two-color laser filament as the source and a spinning gallium phosphide (GaP) crystal as the detector. Compared to ZnTe, GaP has the advantage of a larger THz detection bandwidth due to the higher phonon mode at 11 THz, yet it also has a weaker EO response due to its smaller nonlinear coefficient.²⁰ We show that the system described here can measure the frequency spectrum of polarization angles up to 7 THz with the overall precision of 1.6°. Furthermore, we have demonstrated the feasibility of our system by characterizing two anisotropic samples in the transmission and reflection geometries. Our THz-TDP technique can be implemented readily in standard THz-TDS systems using different combinations of nonlinear crystals.

In our previous report,¹⁷ we demonstrated the precision of the THz-TDP system in the frequency range of 0.1–1.4 THz. We found that if we rotate the (110)-cut EO crystal with an angular frequency of ω , the time-dependent balanced signal $\Delta I(t)$ is described by

$$\Delta I(t) \propto E_{\text{THz}} \left[\frac{1}{2} \cos(\omega t + \beta_0 + \gamma) + \frac{3}{2} \cos(3\omega t + 3\beta_0 - \gamma) \right], \quad (1)$$

where the x -direction is defined as the polarization direction of the probe beam, γ is the polarization angle of THz waves, and β_0 is the initial angle (at $t = 0$) of the crystal axis $[-110]$, both with respect to the x -axis. The amplitude and phase of the ω and 3ω terms in Eq. (1) can be used to extract the THz E -field strength E_{THz} and its polarization angle γ simultaneously. A lock-in type instrument was designed to obtain more stable measurements.¹⁷ In this Letter, we focus on

extending the reliable bandwidth of our system to 7 THz without changing the measurement technique.

Figure 1 shows the experimental setup. A two-color laser plasma was created by focusing a 35 fs, 800 nm laser through a 100 μm type-I β -barium borate (BBO) crystal. The amplified laser at the repetition rate of $f = 1$ kHz is modulated by an optical chopper with the rotation frequency of $f/2$. The polarization-sensitive detection was based on the electro-optic response of a 300 μm thick (110)-cut GaP crystal. This crystal was mounted on a hollow shaft motor rotating at an angular frequency of $\omega = 2\pi f/31$. The Fourier transform of the balanced detector signal $\Delta I(t)$ collected over every two revolutions (i.e., 62 ms) was calculated, and the frequency components at ω and 3ω were used to extract the amplitude E_{THz} and polarization angle γ , following the same procedure described previously.¹⁷ Figure 2 presents the distribution of the polarization angle γ with a fixed polarization state of the THz source over 1000 repeats of extraction. The standard deviation at a constant time delay is calculated to be about 1.6°.

Subsequently, we obtained the entire THz waveform as a function of the time delay. At each time-delay t_0 , the amplitude E_{THz} and argument angle γ of $\vec{E}(t_0)$ were determined using the procedure above. Dried nitrogen gas was purged into the setup box to reduce the absorption of water vapor and enhance the signal bandwidth in the frequency domain. A typical time-domain signal is shown in Fig. 3(a) by averaging five repeated reference measurements. The corresponding frequency spectra in Fig. 3(b) show a maximum electric-field signal-to-noise ratio of 35 dB around 2 THz with a noise-equivalent bandwidth of 8 THz in both the x - and y -components.

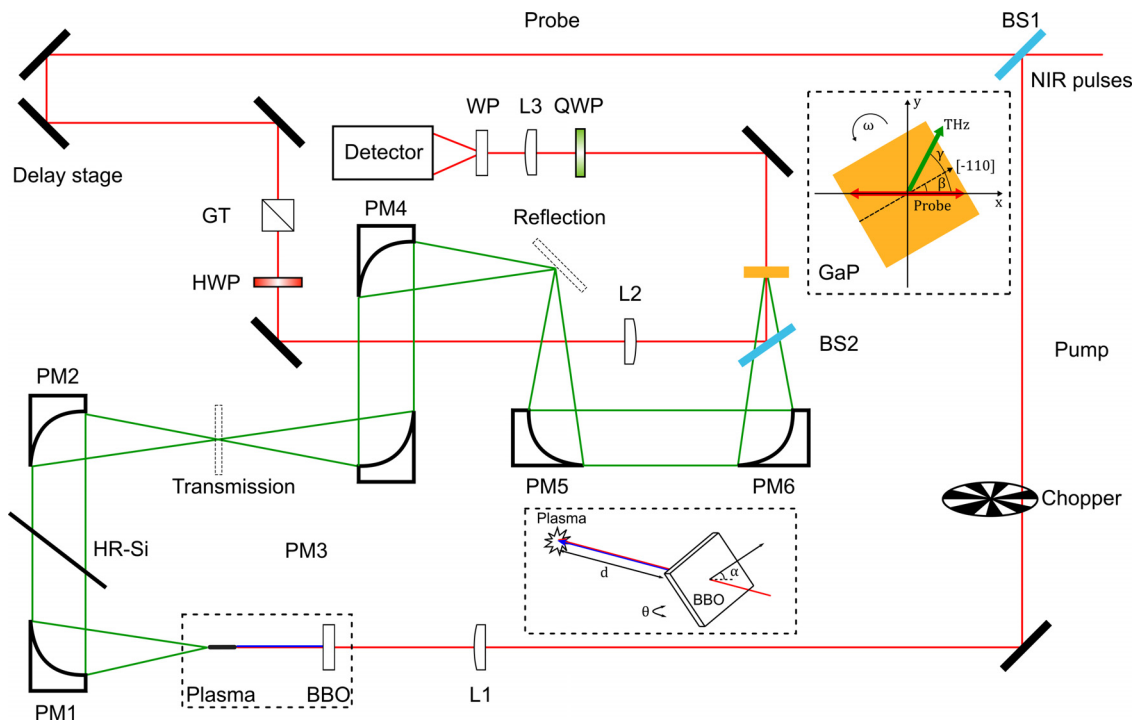


FIG. 1. Schematic illustration of the experimental setup. An 800 nm pump beam is focused through a BBO crystal to create a plasma that radiates THz fields. The GaP detector is rotating at a constant frequency ω and produces time-dependent balanced signals $\Delta I(t)$. Subsequently, the amplitude and angle γ of the THz electric field vector are extracted from the Fourier transform of $\Delta I(t)$. Inset: manipulation of polarization for the THz source by adjusting the BBO crystal.

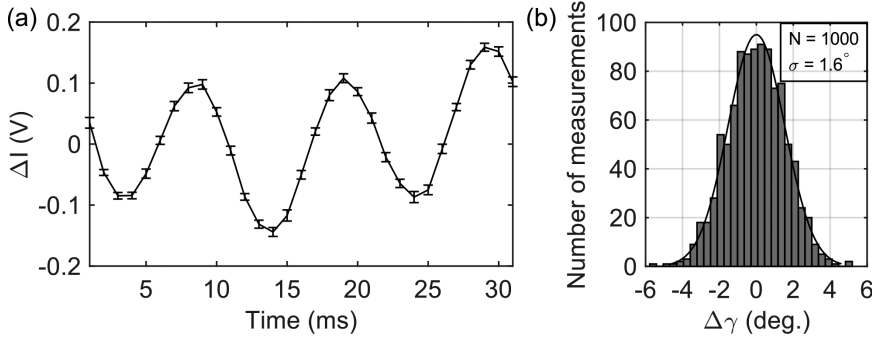


FIG. 2. (a) The balanced signal ΔI induced by the THz E-field as a function of time when the GaP detector spins with the constant period of 31 ms. We used $N=1000$ measurements to calculate the mean value and the standard deviation of ΔI . (b) The distribution of the E-field polarization angle γ . $\Delta\gamma$ denotes the deviation from the mean value $\bar{\gamma}$.

We can describe the THz waveform $\vec{E}(t)$ by the azimuthal angle Ψ and phase difference Δ of the polarization ellipse

$$\frac{\tilde{E}_y(\omega)}{\tilde{E}_x(\omega)} = \tan \Psi e^{i\Delta}, \quad (2)$$

where $\tilde{E}_x(\omega)$ and $\tilde{E}_y(\omega)$ are the complex frequency spectrum of the x - and y -components of $\vec{E}(t)$, respectively. The standard deviation of Ψ using the measurements in Fig. 3(b) was less than 1.9° between 0.7 and 7 THz (not shown), which shows the reliability of high-frequency polarimetric measurements using this technique.

Controlling the polarization states of THz emission from air plasma is necessary for the complete characterization of the Jones matrices. Here, the polarization control was achieved by adjustments to the BBO crystal. Previously, it is shown that the polarization of THz emission is sensitive to the phase difference between the fundamental and second harmonic fields.^{18,19,21,22} We varied this phase difference by translating the position of the BBO crystal with respect to the plasma. The THz polarization continuously rotates as the distance between BBO and the plasma is changed in the range of 4.9–7.5 cm by a 0.2 cm interval. However, the change in the BBO position results in an oscillation in the maximum THz amplitude $|E_{\text{THz}}|$. This oscillation can be reduced by adjusting the BBO tilt angle θ . Figure 4(a) presents the $|E_{\text{THz}}|$ as a function of the BBO position at four representative tilt angles θ . It can be noted that for $\theta = -0.15^\circ, 0.45^\circ, 0.75^\circ$, and 1.20° ,

the ratio between the maximum and minimum $|E_{\text{THz}}|$ in the sinusoidal curves was 4.60, 2.52, 1.98, and 1.74, respectively. Figure 4(b) shows the resultant polarization states for the two cases where $\theta = 1.2^\circ$ and -0.15° . In our setup, for conventional TDS measurement that only requires one polarization component, we can use $\theta = -0.15^\circ$ to achieve a higher dynamic range. For THz-TDP measurements, however, we can use $\theta = 1.20^\circ$ to work with different THz polarization angles without dramatic reduction in the precision of polarization detection.

The amplitude modulation through θ is explained by the two-dimensional transverse electron current in the plasma.^{21,22} The laser field E_L in the plasma at time t is given by

$$E_L(t) = E_\omega [\cos(\omega t) \cos \alpha \hat{e} + \cos(\omega t + \Gamma) \sin \alpha \hat{o}] + E_{2\omega} \cos(2\omega t + \varphi) \hat{e}, \quad (3)$$

where E_ω and $E_{2\omega}$ are the amplitudes of the fundamental and the second harmonic beam, respectively, \hat{e} and \hat{o} are the unit vectors of the extraordinary and ordinary crystalline axes of the BBO crystal, respectively, Γ is the phase retardation between \hat{e} and \hat{o} directions for 800 nm field, α is azimuthal angle of \hat{e} with respect to the x -axis (as shown in Fig. 1), and φ is the relative phase between E_ω and $E_{2\omega}$. In the photocurrent model, THz radiation from the two-color laser filament arises from the transverse electron current J driven by the asymmetric E_L . The relation between J and E_L is described by

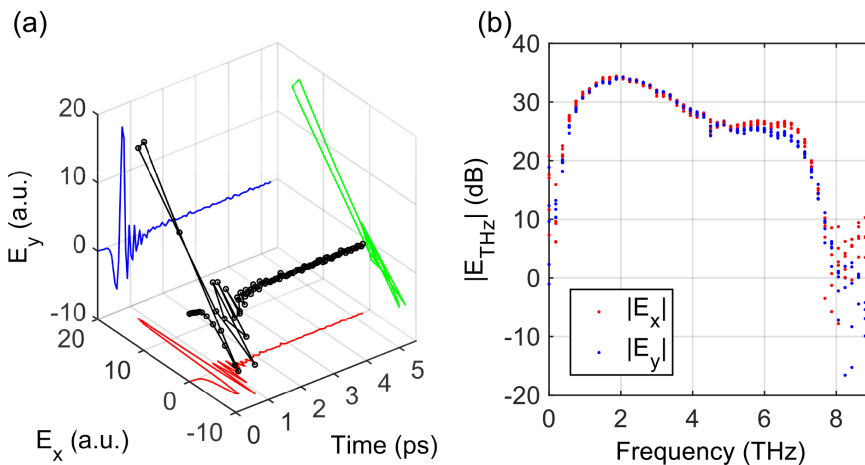


FIG. 3. (a) The 3D temporal waveform of a typical THz pulse generated from a plasma filament. (b) The corresponding frequency spectrum of the x - and y -components.

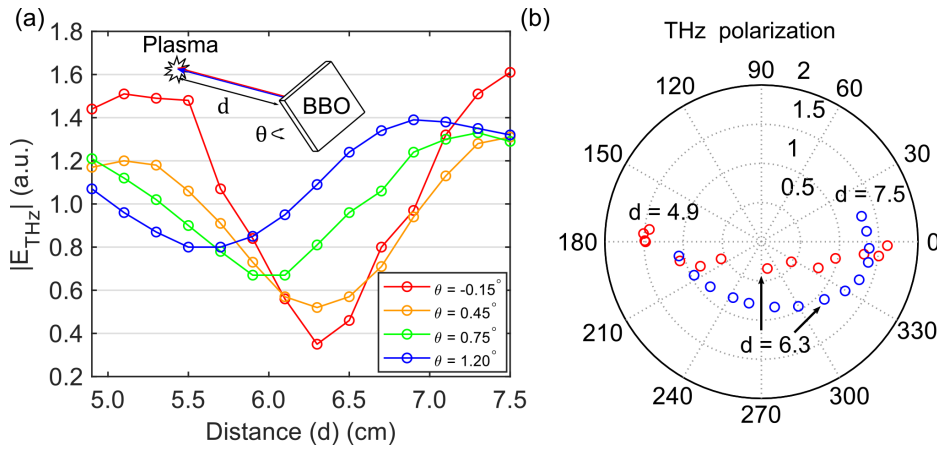


FIG. 4. (a) The relation between the THz amplitude and BBO-to-plasma distance d under different BBO tilt angles θ . (b) The relation between the THz electric vectors and d obtained when $\theta = 1.2^\circ$ (blue) and $\theta = -0.15^\circ$ (red).

$$\dot{j}(t) + \nu j(t) = \frac{e^2}{m_e} E_L(t) N_e(t), \quad (4)$$

with electron charge e and mass m_e . The electron collision frequency ν can be neglected in simplified calculations, while the electron density $N_e(t)$ in the plasma is calculated using the static tunneling ionization rate described in Ref. 23. The electron current density J is two-dimensional since the laser field E_L has two orthogonal components in our experimental condition. We apply the Fourier transform to both sides of Eq. (4) and use the low frequency spectrum of \dot{j} to estimate the intensity of THz emission. Figure 5 shows that the phase retardation of BBO (Γ) strongly affects the ratio of minimum to maximum THz amplitude during 2π radians change of the relative phase φ . In our system, φ is adjusted by translating the position of BBO, and Γ is controlled by tilting the BBO and, thus, varying the effective thickness of the crystal. Hence, the two-dimensional transverse current model has provided a qualitative explanation on the trend observed in Fig. 4.

To demonstrate the broadband capability of the THz-TDP system, we first measured the anisotropic properties of crystal quartz. A 3.0 mm thick A-cut quartz crystal (Newlight Photonics) was tested in the transmission mode to obtain the optical parameters for both the e- and o-axes concurrently in one TDP measurement. The sample was kept at the certain azimuthal angle such that its o-axis would be

parallel to the laboratory y -direction. Figure 6(a) shows that the phonon resonance at 3.9 THz of the o-axis can be resolved in the transmission spectrum of E_y , while E_x does not show this feature. The extracted refractive indices for the e- and o-axes in the sample are presented in Fig. 6(b), which are in agreement with the previous Fourier-transform infrared spectroscopy (FT-IR) measurement.²⁴

As a second TDP demonstration, we performed reflection measurements on a natural calcite sample. This sample was designed as a group velocity dispersion (GVD) compensation plate (Eksma Optics) with the thickness of 1.7 mm, which exhibits strong absorption above 2 THz.²⁶ The crystal's labeled c-axis was oriented such that $E_x \perp c$, and $E_y \parallel c$. Figure 7 shows that the reflection spectrum of E_x has two peaks, which correspond to the two E_u mode at 3.06 and 6.68 THz. Meanwhile, the spectrum of E_y contains only one peak, which corresponds to the A_{2u} mode at 2.76 THz. We have calculated the theoretical reflection spectra of calcite using the Lorentz oscillation parameters reported in Ref. 25, which shows excellent agreement with the broadband TDP measurements.

In conclusion, we have demonstrated a broadband THz-TDP system by using the air plasma as the source and the GaP crystal as the detector. We showed that the polarization angle of THz pulses can be extracted at a fixed time delay with a precision of approximately 1.6°

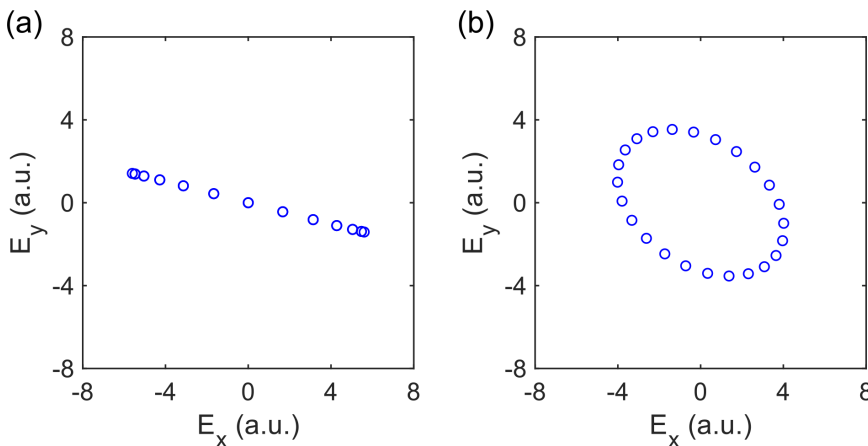


FIG. 5. The simulation results confirm the dependence of the THz polarization angle and amplitude on the relative phase φ when (a) $\Gamma = 0^\circ$ and (b) $\Gamma = 90^\circ$. Γ is the phase retardation of the 800 nm field between \hat{e} and \hat{o} directions.

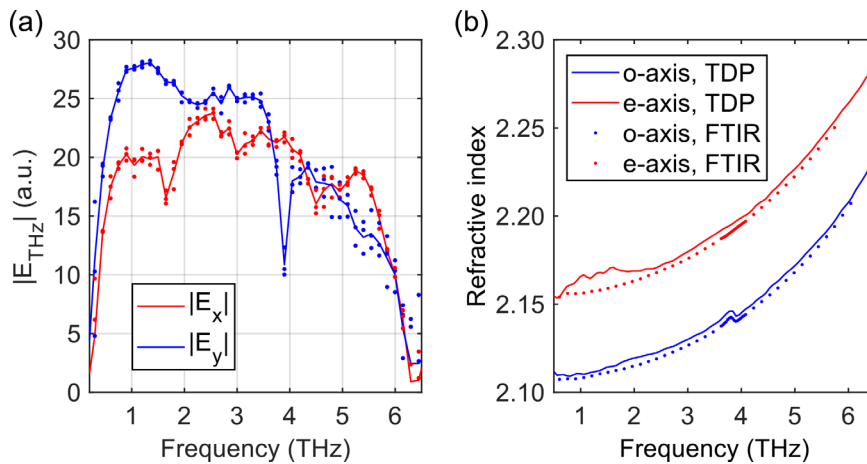


FIG. 6. (a) Spectra for the THz waves transmitted through a A-cut quartz crystal. The o-axis of quartz is aligned with the component E_y (blue), while the e-axis is aligned with E_x (red). The extracted refractive indices of the e- and o-axes (b) are similar to the FT-IR measurements described in Ref. 24.

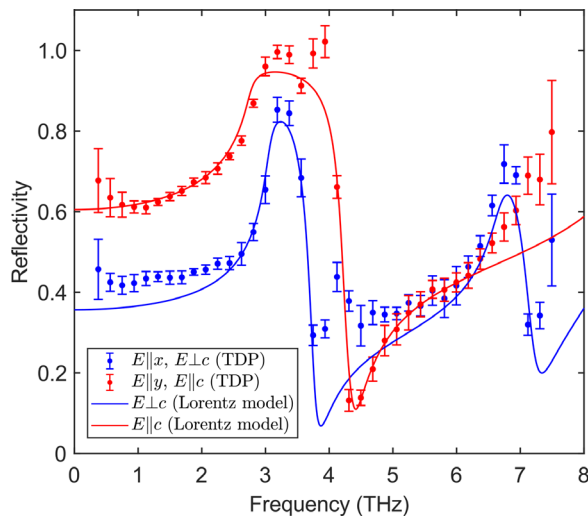


FIG. 7. Reflection spectra of calcite (45° angle of incidence) for polarization components E_x and E_y compared with the calculations using Lorentz oscillator parameters from Ref. 25.

and the frequency-dependent rotation angle with a precision of about 1.9° between 0.7 and 7 THz. We have investigated the polarization control of THz waves generated in two-color laser filaments as a function of the position of BBO and its tilt angle. When rotating the polarization, we observed that the oscillation in the THz amplitudes can be compensated by the BBO tilt angle. This phenomenon was explained by the phase retardation induced by the BBO crystal and a two-dimensional photocurrent model. Subsequently, we have measured the transmission spectra of quartz and the reflection spectra of calcite to demonstrate the extended bandwidth of our system. This THz-TDP system provides a unique approach for broadband polarization measurements in the THz regime.

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AUTHOR DECLARATIONS

Conflict of Interest

The authors have no conflicts to disclose.

DATA AVAILABILITY

The data that support the findings of this study are available from the corresponding author upon reasonable request.

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